Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/723,174	KNEIPP ET AL.	
Examiner	Art Unit	
la-Na Hines	1645	

	SEAR	CHED	
Class	Subclass	Date	Examiner
356	300, 451	10/31/2005	JAH
424	93		
435	6, 7.95		
436	89		
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INT	INTERFERENCE SEARCHED		
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
West, stic, caplus, medline, scisearch, eplus, japio, biosis, wpids, commercail databases, inventor search	10/31/2005	JAH
related applications searched		
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